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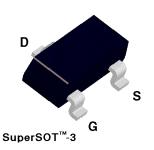
# NDS355AN N-Channel Logic Level Enhancement Mode Field Effect Transistor

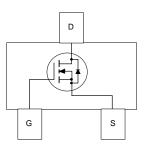
#### **General Description**

SuperSOT<sup>™</sup>-3 N-Channel logic level enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage applications in notebook computers, portable phones, PCMCIA cards, and other battery powered circuits where fast switching, and low in-line power loss are needed in a very small outline surface mount package.

#### Features

- 1.7A, 30 V,  $R_{DS(ON)} = 0.125 \Omega @ V_{GS} = 4.5 V$  $R_{DS(ON)} = 0.085 \Omega @ V_{GS} = 10 V.$
- Industry standard outline SOT-23 surface mount package using proprietary SuperSOT<sup>™</sup>-3 design for superior thermal and electrical capabilities.
- High density cell design for extremely low R<sub>DS(ON)</sub>.
- Exceptional on-resistance and maximum DC current capability.
- Compact industry standard SOT-23 surface mount package.

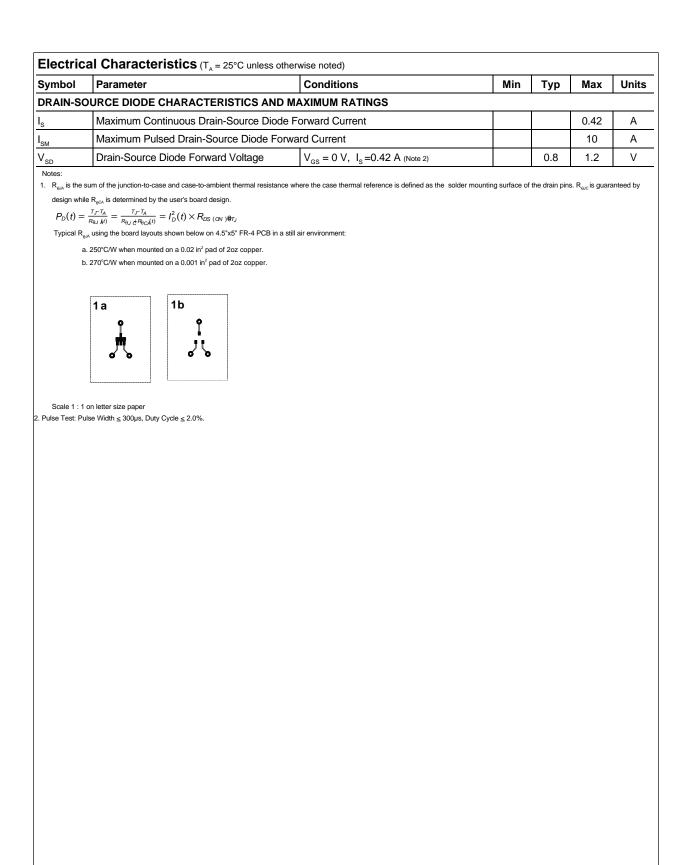


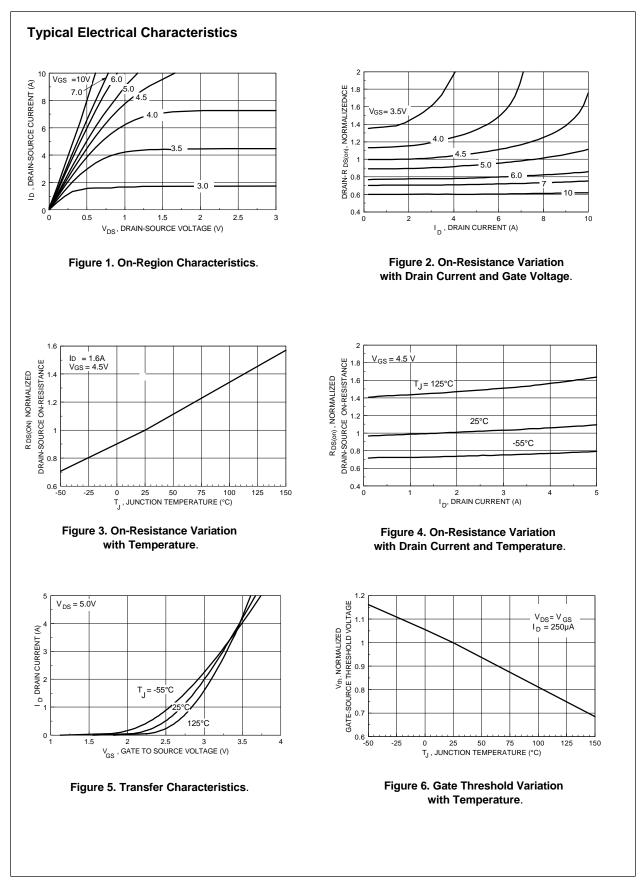


### Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

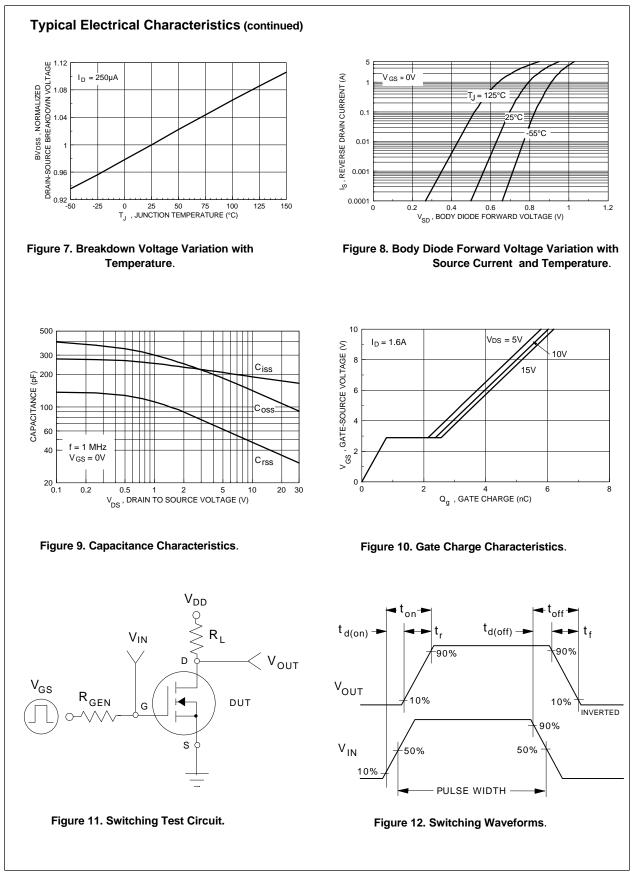
Symbol	Parameter		NDS355AN	Units	
V <sub>DSS</sub>	Drain-Source Voltage		30	V	
V <sub>GSS</sub>	Gate-Source Voltage - Continuous		±20	V	
I <sub>D</sub>	Maximum Drain Current - Continuous	(Note 1a)	1.7	А	
	- Pulsed		10		
P <sub>D</sub>	Maximum Power Dissipation	(Note 1a)	0.5	W	
		(Note 1b)	0.46		
T_,T <sub>stg</sub>	Operating and Storage Temperature Range		-55 to 150	°C	
THERMA	L CHARACTERISTICS	·		·	
R <sub>eja</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	250	°C/W	
R <sub>euc</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	75	°C/W	

Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHA	RACTERISTICS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 µA		30			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$				1	μA
			T <sub>J</sub> =125°C			10	μA
	Gate - Body Leakage, Forward	V <sub>GS</sub> = 20 V <sub>DS</sub> = 0 V				100	nA
I <sub>GSSR</sub>	Gate - Body Leakage, Reverse	$V_{gs} = -20 \text{ V}, V_{ps} = 0 \text{ V}$				-100	nA
ON CHAR	ACTERISTICS (Note 2)						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = 250 \ \mu {\rm A}$		1	1.6	2	V
			T <sub>J</sub> =125°C	0.5	1.2	1.5	
R <sub>ds(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 1.7 A			0.105	0.125	Ω
			T <sub>J</sub> =125°C		0.16	0.23	
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.9 A			0.065	0.085	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$		6			А
9 <sub>FS</sub>	Forward Transconductance	$V_{\rm DS} = 5 \text{ V}, \text{ I}_{\rm D} = 1.7 \text{ A}$			3.5		S
DYNAMIC	CHARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1.0 MHz			195		pF
C <sub>oss</sub>	Output Capacitance				135		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				48		pF
SWITCHI	NG CHARACTERISTICS (Note 2)						
t <sub>d(on)</sub>	Turn - On Delay Time	$V_{DD} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$			10	20	ns
t,	Turn - On Rise Time				13	25	ns
t <sub>d(off)</sub>	Turn - Off Delay Time				13	25	ns
t <sub>r</sub>	Turn - Off Fall Time				4	10	ns
t <sub>d(on)</sub>	Turn - On Delay Time	$V_{DD} = 5 V, I_D = 1 A,$ $V_{GS} = 4.5 V, R_{GEN} = 6 Ω$			10	20	ns
t <sub>r</sub>	Turn - On Rise Time				32	60	ns
t <sub>d(off)</sub>	Turn - Off Delay Time				10	20	ns
t <sub>r</sub>	Turn - Off Fall Time				5	10	ns
Q <sub>g</sub>	Total Gate Charge	$V_{\rm DS} = 10 \text{ V}, \text{ I}_{\rm D} = 1.7 \text{ A},$ $V_{\rm GS} = 5 \text{ V}$			3.5	5	nC
Q <sub>gs</sub>	Gate-Source Charge				0.8		nC
Q <sub>gd</sub>	Gate-Drain Charge				1.7		nC

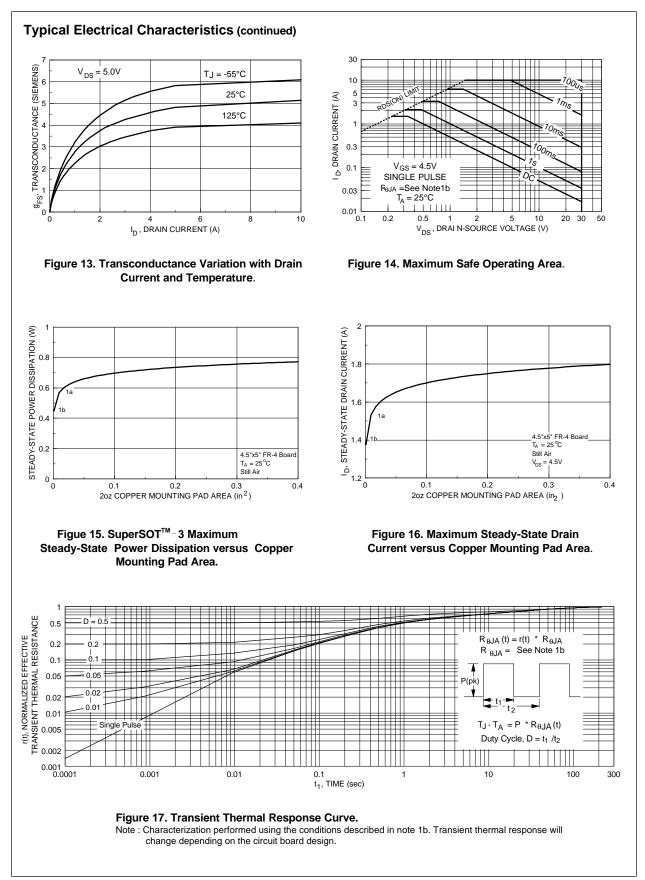




NDS355AN Rev.C



NDS355AN Rev.C



NDS355AN Rev.C

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